Notice of References Cited Application/Control No. Applicant(s)/Patent Under Reexamination HALWAN ET AL. Examiner Chen-Wen Jiang Application/Control No. Applicant(s)/Patent Under Reexamination HALWAN ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,477,696 A	12-1995	Takahata et al.	62/148
	В	US-			
	C	US-			
	D	US-		_	
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	_	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 05248726 A	09-1993	Japan	IZUMI et al.	F25B 15/00
	0	JP 10300263 A	11-1998	Japan	UBUKATA et al.	F25B 15/00
	Р	JP 2002013834 A	01-2002	Japan	NAKAMURA et al.	F25B 15/00
	Q					
	R					
	S					:
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.